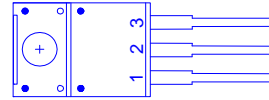
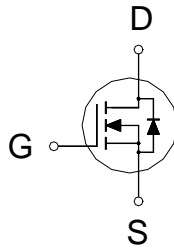




PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
250V	260mΩ	15A



- 1. GATE
- 2. DRAIN
- 3. SOURCE

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	250	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current	$T_C = 25\text{ }^\circ\text{C}$	I_D	15	A
	$T_C = 100\text{ }^\circ\text{C}$		9.4	
Pulsed Drain Current ¹		I_{DM}	60	
Avalanche Current		I_{AS}	7.6	
Avalanche Energy	$L = 1\text{mH}$	E_{AS}	29	mJ
Power Dissipation	$T_C = 25\text{ }^\circ\text{C}$	P_D	37	W
	$T_C = 100\text{ }^\circ\text{C}$		15	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATING

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		3.3	°C / W
Junction-to-Ambient	$R_{\theta JA}$		62.5	

¹Pulse width limited by maximum junction temperature.

ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	250			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1	2	3	V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			±100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 250\text{V}, V_{GS} = 0\text{V}$			1	μA
		$V_{DS} = 200\text{V}, V_{GS} = 0\text{V}, T_J = 125\text{ }^\circ\text{C}$			10	

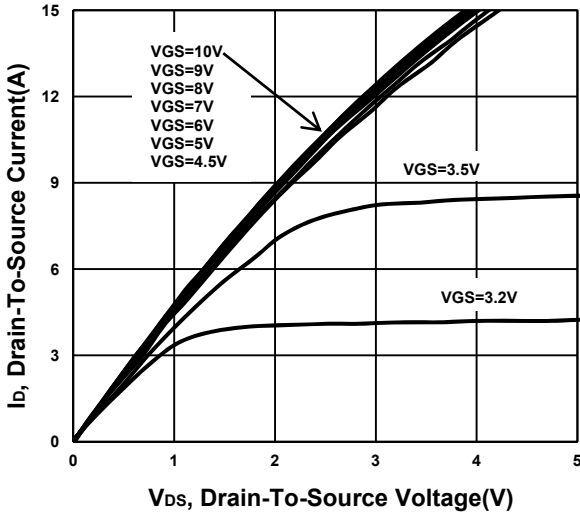
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 7.5A$	200	260	mΩ
		$V_{GS} = 4.5V, I_D = 7.5A$	216	310	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 10V, I_D = 7.5A$	13		S
DYNAMIC					
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$	861		pF
Output Capacitance	C_{oss}		126		
Reverse Transfer Capacitance	C_{rss}		17		
Total Gate Charge ²	Q_g	$V_{DS} = 200V, V_{GS} = 10V,$ $I_D = 15A$	27.5		nC
Gate-Source Charge ²	Q_{gs}		3		
Gate-Drain Charge ²	Q_{gd}		9.5		
Turn-On Delay Time ²	$t_{d(on)}$	$V_{DD} = 125V,$ $I_D \cong 15A, V_{GS} = 10V, R_{GEN} = 6\Omega$	16		nS
Rise Time ²	t_r		42		
Turn-Off Delay Time ²	$t_{d(off)}$		51		
Fall Time ²	t_f		63		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25\text{ }^\circ\text{C}$)					
Continuous Current ³	I_S			15	A
Forward Voltage ¹	V_{SD}	$I_F = 15A, V_{GS} = 0V$		1	V
Reverse Recovery Time	t_{rr}	$I_F = 15A, di_F/dt = 100A / \mu S$	154		nS
Reverse Recovery Charge	Q_{rr}		0.7		uC

¹Pulse test : Pulse Width $\leq 300\ \mu\text{sec}$, Duty Cycle $\leq 2\%$.

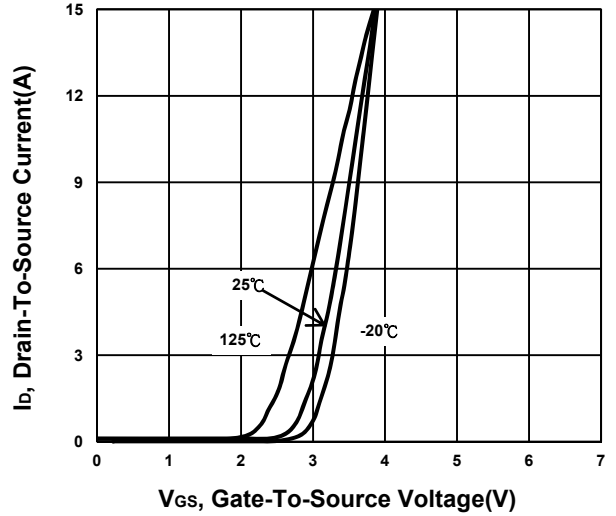
²Independent of operating temperature.

³Pulse width limited by maximum junction temperature.

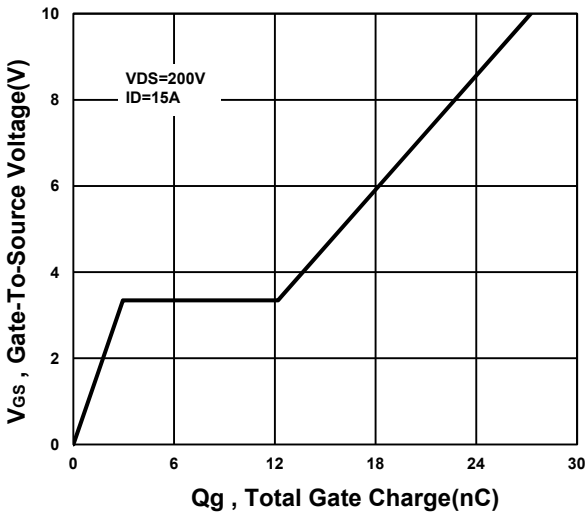
Output Characteristics



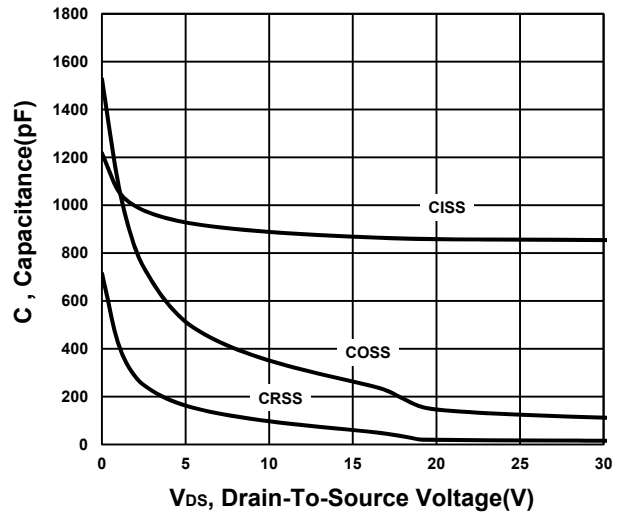
Transfer Characteristics



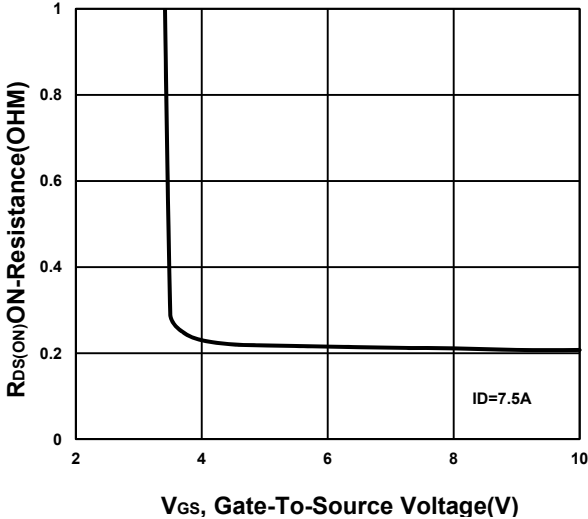
Gate charge Characteristics



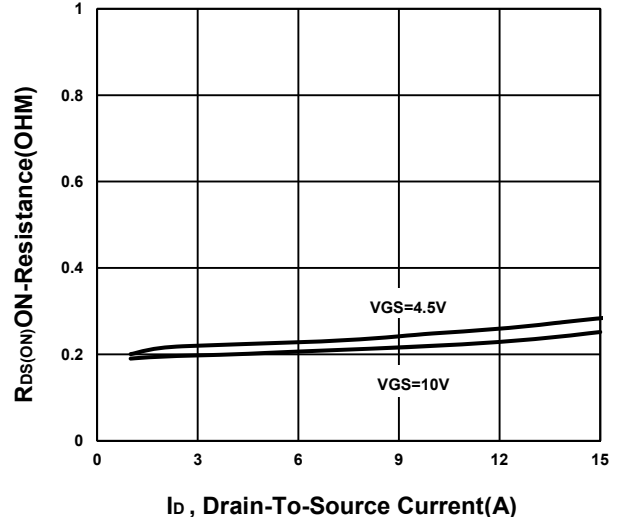
Capacitance Characteristic



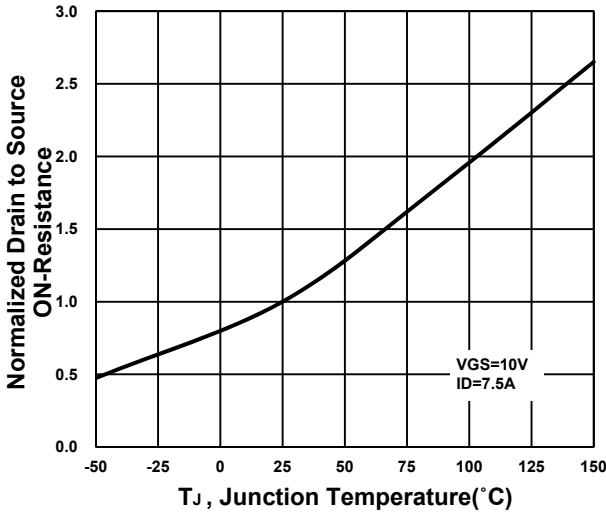
On-Resistance VS Gate-To-Source



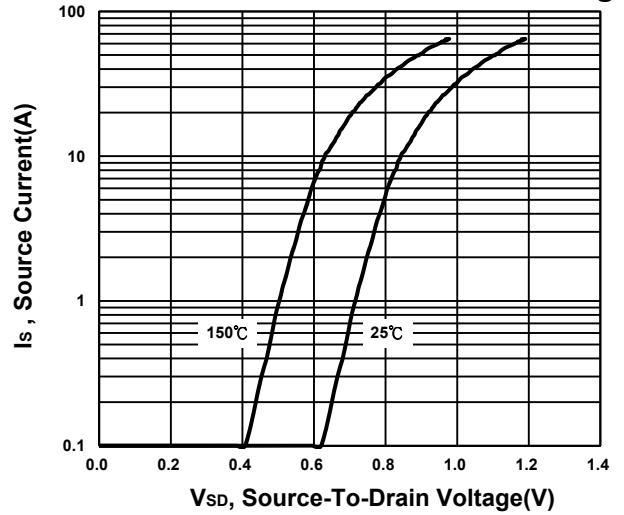
On-Resistance VS Drain Current



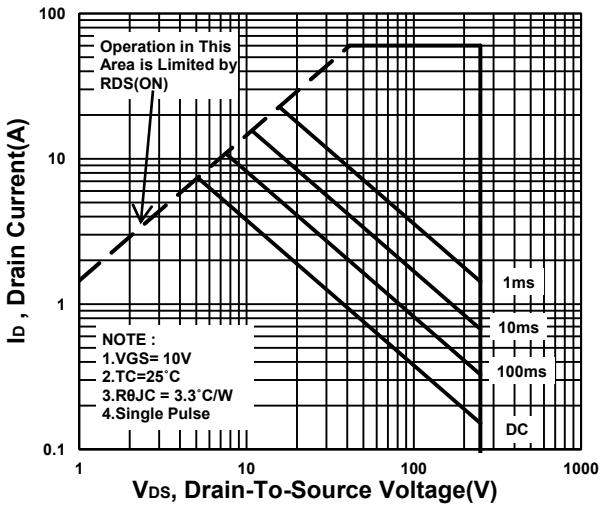
On-Resistance VS Temperature



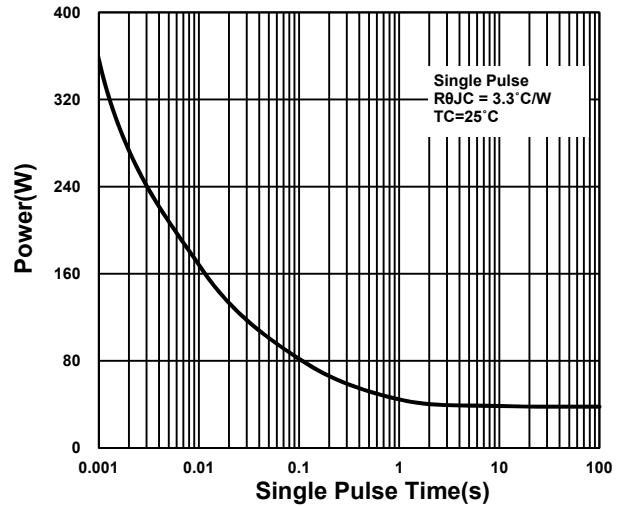
Source-Drain Diode Forward Voltage



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

